

Atta: Docket No.: CPM03008 (3600-421-01) Application No.: 10/786,621 Applicant: REED et al. Filing Date: February 25, 2004 Group Art Unit: Unassigned **U.S. PATENT DOCUMENTS** Examiner Document Date Name Class Sub Filing Date Initial* Number Class If Appropriate 2002/0135973 A1 9/26/02 Kimmel et al. 509 361 /D.L./ 2002/0114722 8/22/02 Kimmel et al. 419 45 2003/0104923 A1 6/5/03 Omori et al. 501 134 3/7/2002 2002/0028175 Fife 423 592 2003/0117766 A1 06/26/03 Naito et al. 361 305 2003/0147203 A1 08/07/03 Naito et al. 361 524 2003/0170169 A1 09/11/03 Omori et al. 423 592.1 2003/0205106 A1 11/06/03 Omori et al. 75 245 2003/0230167 A1 12/18/03 Loeffelholz et al. 75 255 5/9/22 1,415,516 Bridge 1,906,184 4/25/33 Bohn 12/12/39 2,183,517 Leemans, et al. 75 135 2,242,759 5/20/41 Schlecht et al. 75 84 2,443,524 6/1948 Kroll et al. 423 62 12/9/52 Miller 2,621,137 148 13.1 2,700,606 1/25/55 Wilhelm et al. 75 84 2,761,776 9/4/56 **Bichowsky** 75 5 2,861,882 11/25/58 **Bichowsky** 75 84 Wilhelm et al. 2,937,939 5/24/60 75 84 Li 2,992,095 7/11/61 75 27 3,421,195 12/23/65 Berryhill 29 25.42 3,647,420 3/1972 Restelli 75 84 5-1972 3,665,260 Kirkpatrick et al. 361 529 3,849,124 11/1974 Villani 420 422 3,926,832 12/16/75 Barosi 252 181.6 4,032,328 6/28/77 Hurd 84.1 75 4,059,442 11/1977 Bernard 75 208R 4,126,493 11/21/78 Wurm 148 20 4,186,423 1/1980 Yoshida et al. 361 525

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